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fo.	AA	4,941,026	07/10/90	TEMPLE			
PB	AB	5,637,898	06/10/97	BALIGA			
Pr	AC	5,679,966	10/21/97	BALIGA ET AL.			
Re	AD	5,844,273	12/01/98	KONISHI			
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	AW	BALIGA, B. J., "Critical on Semiconductors, \	al Nature of Oxi	Including Author, Title, Date, Pertin de/Interface Quality for SiC Power De France, 7-10 June 1995, Microelectro 8, no. 1-4, pages 177-184.	vices". 9 <sup>th</sup> Bic	ennial Confe	erence on Insulating Film 995, Elsevier Publishers
	AX	b.v., Anaterdam, Ne	menands, voi. 2	o, no. 1-4, pages 177-104.			
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INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
Pa	AA	4,941,026	07/10/90	TEMPLE				
Po	AB	5,637,898	06/10/97	BALIGA				
Pr	AC	5,679,966	10/21/97	BALIGA ET AL.				
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